


<b>Search Notes</b>  	<b>Application/Control No.</b>  10574425	<b>Applicant(s)/Patent Under Reexamination</b>  LINDH, HANS
	<b>Examiner</b>  PAUL T CHIN	<b>Art Unit</b>  3652

SEARCHED			
Class	Subclass	Date	Examiner
294	19.2	6/21/07	ptc
473	286	12/3/09	ptc

SEARCH NOTES		
Search Notes	Date	Examiner
Searched (294/19.2)	6/21/07 and 8/12/08	ptc

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
294	19.2	12/3/09	ptc
Interference Text EAST Search (see Search History Printout)		12/3/09	ptc
473	286	12/3/09	ptc

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